

Dual P-Channel 2.5V Specified PowerTrench[®] MOSFET

General Description

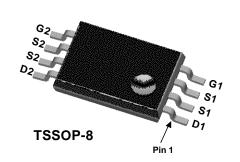
This P-Channel 2.5V specified MOSFET is a rugged gate version of Fairchild's Semiconductor's advanced PowerTrench process. It has been optimized for power management applications with a wide range of gate drive voltage (2.5V - 12V).

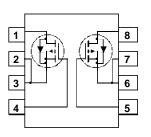
Applications

- · Load switch
- Motor drive
- DC/DC conversion
- Power management

Features

- -4.4 A, -20 V. $R_{DS(ON)} = 0.035 \ \Omega \ @ V_{GS} = -4.5 \ V$ $R_{DS(ON)} = 0.057 \ \Omega \ @ V_{GS} = -2.5 \ V.$
- Extended V_{GSS} range (±12V) for battery applications.
- High performance trench technology for extremely low $R_{\text{DS}(\text{ON})}$.
- Low profile TSSOP-8 package.





Absolute Maximum Ratings TA=25°C unless otherwise noted

| Symbol | | Parameter | | Ratings | Units |
|-----------------------------------|---|--|----------------------------|-------------|------------|
| V _{DSS} | Drain-Source Voltage | | | -20 | V |
| V _{GSS} | Gate-Sourc | e Voltage | | ±12 | V |
| I _D | Drain Curre | nt – Continuous | (Note 1a) | -4.4 | A |
| | | Pulsed | | -30 | |
| PD | Power Diss | ipation for Single Opera | ation (Note 1a) | 1.0 | W |
| | | | (Note 1b) | 0.6 | |
| T _J , T _{stg} | Operating a | Dperating and Storage Junction Temperature Range | | -55 to +150 | °C |
| Therma | I Charac | teristics | | | |
| $R_{\theta JA}$ | Thermal Resistance, Junction-to-Ambient (Note 1a) | | | 125 | °C/W |
| | | | (Note 1b) | 208 | |
| - | | g and Ordering | g Information Reel Size | Tape width | Quantity |
| Device Marking | | | | • | |
| 250 | 2P | FDW2502P | 13" | 12mm | 3000 units |

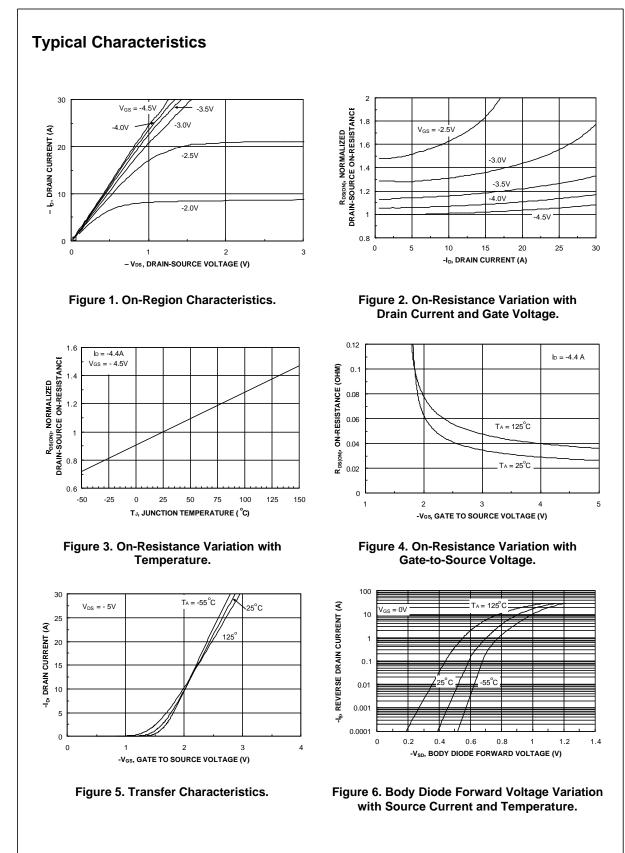
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FDW2502P Rev. C1 (W)

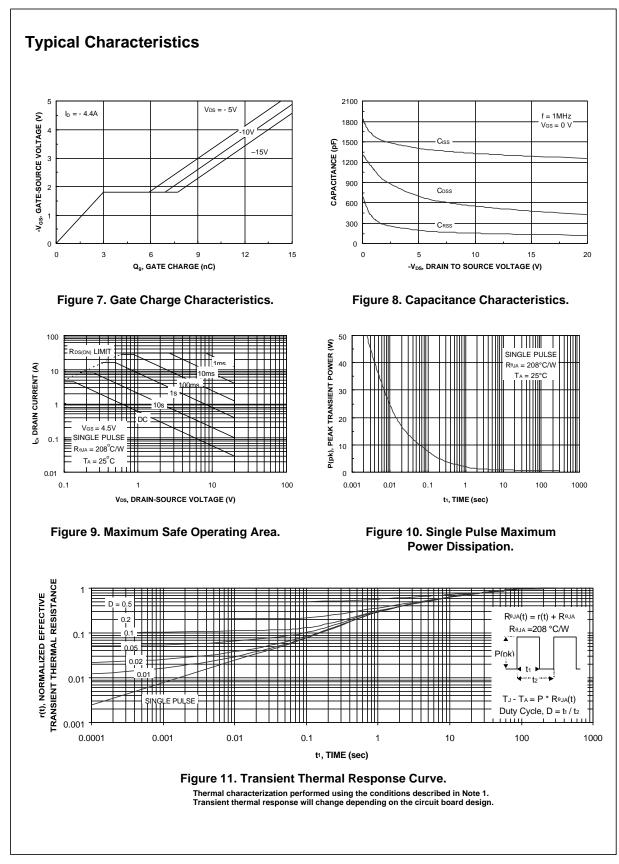
| Symbol | Parameter | Test Conditions | Min | Тур | Max | Unit |
|--|---|--|------|-------------------------|-------------------------|------|
| Off Chai | racteristics | | | | | |
| BV _{DSS} | Drain-Source Breakdown Voltage | $V_{GS} = 0 V, I_D = -250 \mu A$ | -20 | | | V |
| $\frac{\Delta BV_{DSS}}{\Delta T_J}$ | Breakdown Voltage Temperature Coefficient | $I_D = -250 \ \mu$ A, Referenced to 25°C | | -17 | | mV/° |
| I _{DSS} | Zero Gate Voltage Drain Current | $V_{DS} = -16 \text{ V}, V_{GS} = 0 \text{ V}$ | | | -1 | μA |
| I _{GSSF} | Gate-Body Leakage, Forward | $V_{GS} = -12 V$, $V_{DS} = 0 V$ | | | -100 | nA |
| I _{GSSR} | Gate-Body Leakage, Reverse | $V_{GS} = 12 V$ $V_{DS} = 0 V$ | | | 100 | nA |
| On Char | acteristics (Note 2) | | | | | |
| V _{GS(th)} | Gate Threshold Voltage | $V_{DS} = V_{GS}, I_D = -250 \ \mu A$ | -0.4 | -1.0 | -1.5 | V |
| $\frac{\Delta V_{GS(th)}}{\Delta T_J}$ | Gate Threshold Voltage Temperature Coefficient | $I_D = -250 \ \mu$ A, Referenced to 25° C | | 3.1 | | mV/° |
| R _{DS(on)} | Static Drain–Source On–Resistance | $ \begin{array}{l} V_{GS} = -4.5 \ V, I_D = -4.4 \ A \\ V_{GS} = -4.5 \ V, \ I_D = -4.4 \ , T_J = 125^\circ C \\ V_{GS} = -2.5 \ V, I_D = -3.3 \ A \end{array} $ | | 0.028 0.039 0.043 | 0.035 0.056 0.057 | Ω |
| I _{D(on)} | On-State Drain Current | $V_{\text{GS}} = -4.5 \text{ V}, \qquad V_{\text{DS}} = -5 \text{ V}$ | -30 | | | А |
| g _{FS} | Forward Transconductance | $V_{DS} = -5 V$, $I_{D} = -4.4 A$ | | 17 | | S |
| Dynamic | c Characteristics | | | | | |
| C _{iss} | Input Capacitance | | | 1330 | | pF |
| C _{oss} | Output Capacitance | $V_{DS} = -10 V$, $V_{GS} = 0 V$, f = 1.0 MHz | | 552 | | pF |
| C _{rss} | Reverse Transfer Capacitance | | | 153 | | pF |
| Switchir | ng Characteristics (Note 2) | | | | | |
| t _{d(on)} | Turn-On Delay Time | | | 12 | 25 | ns |
| tr | Turn–On Rise Time | $V_{DD} = -10 \text{ V}, \qquad I_D = -1 \text{ A},$ | | 19 | 40 | ns |
| t _{d(off)} | Turn–Off Delay Time | $V_{GS} = -4.5$ V, $R_{GEN} = 6 \Omega$ | | 60 | 100 | ns |
| t _f | Turn-Off Fall Time | | | 37 | 70 | ns |
| Q _g | Total Gate Charge | | | 14 | 20 | nC |
| Q _{gs} | Gate-Source Charge | $V_{DS} = -5 V,$ $I_D = -4.4 A,$ $V_{GS} = -4.5 V$ | | 3.0 | | nC |
| Q _{gd} | Gate-Drain Charge | | | 3.9 | | nC |
| Drain-S | ource Diode Characteristics | and Maximum Ratings | | | | |
| Is | Maximum Continuous Drain-Source | v | | | -0.83 | Α |
| V _{SD} | Drain-Source Diode Forward Voltage | $V_{GS} = 0 \text{ V}, I_{S} = -0.83 \text{ A} \text{ (Note 2)}$ | | -0.7 | -1.2 | V |

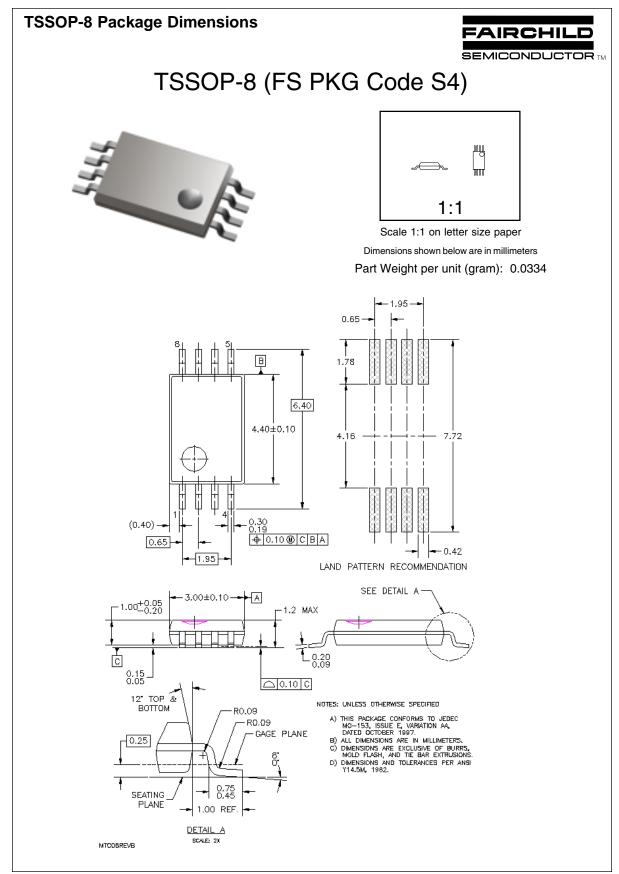
a) R_{eJA} is 125°C/W (steady state) when mounted on a 1 inch² copper pad on FR-4.
b) R_{eJA} is 208°C/W (steady state) when mounted on a minimum copper pad on FR-4.

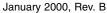
2. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%



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|--------------------------|---------------------------|---|--|--|--|
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